











UC1707-SP

SLUSAG0A - MARCH 2011 - REVISED MARCH 2016

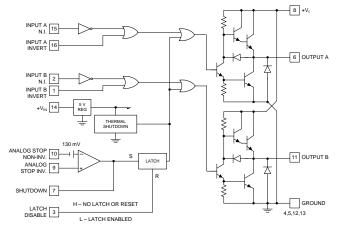
UC1707-SP Dual-Channel Power Driver

1 Features

- Rad-Tolerant: 50 kRad (Si) for 5962-8761903VEA, 5962-8761903VFA (1)
- QML-V Qualified, SMD (5962-8761901VEA, 5962-8761903VEA, 5962-8761903VFA, 5962-8761901V2A)
- Two Independent Drivers
- 1.5-A Totem Pole Outputs
- · Inverting and Non-Inverting Inputs
- 40-ns Rise and Fall Into 1000 pF
- · High-Speed, Power MOSFET Compatible
- Low Cross-Conduction Current Spike
- Analog Shutdown With Optional Latch
- Low Quiescent Current
- 5-V to 40-V Operation
- Thermal Shutdown Protection
- 16-Pin Dual-In-Line Package

2 Applications

- Switch Mode Power Supply
- DC-DC Converter
- Pulse Transformer Driver



(1) Radiation tolerance is a typical value based upon initial device qualification with dose rate = 10 mrad/s. Radiation Lot Acceptance Testing is available - contact factory for details.

3 Description

The UC1707-SP power driver is made with a high-speed Schottky process to interface between low-level control functions and high-power switching devices – particularly power MOSFETs. The UC1707-SP contains two independent channels, each of which can be activated by either a high or low input logic level signal. Each output can source or sink up to 1.5 A as long as power dissipation limits are not exceeded.

Although each output can be activated independently with its own inputs, it can be forced low in common through the action either of a digital high signal at the Shutdown terminal or a differential low-level analog signal. The Shutdown command from either source can either be latching or not, depending on the status of the Latch Disable pin.

Supply voltage for both V_{IN} and V_{C} can independently range from 5 to 40 V.

Device Information(1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)		
	CDIP (16)	6.92 mm × 19.56 mm		
UC1707-SP	CFP (16)	6.73 mm × 10.30 mm		
	LCCC (20)	8.89 mm × 8.89 mm		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Truth Table (Each Channel)⁽¹⁾

	1	
INV.	N.I.	OUT
Н	Н	L
L	Н	Н
Н	L	L
L	L	L

(1) $OUT = \overline{INV}$ and N.I. OUT = INV or N.I.



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Original (March 2011) to Revision A

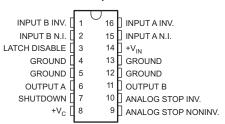
Page

Added ESD Ratings table, Recommended Operating Conditions table, Thermal Information table, Feature
Description section, Device Functional Modes, Application and Implementation section, Power Supply
Recommendations section, Layout section, Device and Documentation Support section, and Mechanical,
Packaging, and Orderable Information section
 Corrected typos in Pin Configuration and Functions
 Deleted package thermal impedance in Absolute Maximum Ratings table

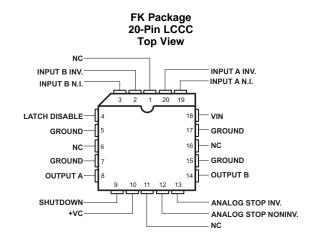


5 Pin Configuration and Functions

J or W Package 16-Pin CDIP or CFP Top View



All four ground pins must be connected to a common ground.



Pin Functions

PIN					
NAME	CDIP	LCCC	CFP	I/O	DESCRIPTION
INPUT B INVERTING	1	2	1	ı	Inverting TTL compatible input threshold.
INPUT B NONINVERTING	2	3	2	ı	Non-Inverting TTL compatible input threshold.
LATCH DISABLE	3	4	3	I	Assuming SHUTDOWN pin is left open, a high on this pin disables the latching functionality of the analog stop shutdown.
GROUND	4	5	4	-	
GROUND	5	7	5	-	
OUTPUT A	6	8	6	0	Output is a 1.5 A totem-pole driver optimized for MOSFET gates.
SHUTDOWN	7	9	7	I	Used as an output of the analog stop circuit. Also used as an input to force shutdown or to force the device out of shutdown.
+V _C	8	10	8	I	Collector supply voltage.
ANALOG STOP (+)	9	12	9	I	This pin is normally connected to a reference voltage used for comparison with the sensed power supply output voltage level at the E/A (+) pin.
ANALOG STOP (-)	10	13	10	I	This pin is normally connected to the voltage divider resistors which sense the power supply output level.
OUTPUT B	11	14	11	0	Output is a 1.5 A totem-pole driver optimized for MOSFET gates.
GROUND	12	15	12	-	All voltages are measured with respect to ground (GND).
GROUND	13	17	13	-	All voltages are measured with respect to ground (GND).
+V _{IN}	14	18	14	I	Supply voltage.
INPUT A NONINVERTING	15	20	15	I	Non-Inverting TTL compatible input threshold.
INPUT A INVERTING	16	19	16	I	Inverting TTL compatible input threshold.
NC		16			
NC		11			
NC		6			
NC		1			

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{IN}	Supply voltage			40	V
V _C	Collector supply voltage			40	V
	Digital inputs (2)			5.5	V
	Output current (each output, source or sink) steady-state	е		±500	mA
	Peak transient			±1	Α
	Capacitive discharge energy			15	mJ
	Analog stop inputs			V _{IN}	
TJ	Operating virtual-junction temperature			150	°C
		J package		13	W
	Power dissipation at T _{case} = 25°C ⁽²⁾	W package		15	W
		FK package		13	W
	Lead temperature (soldering, 10 s)			300	°C
	Operating temperature		-55	125	°C
T _{stg}	Storage temperature		-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±2000	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{IN}	Supply voltage	5	12	38	V
V _C	Supply voltage	5	12	38	V

6.4 Thermal Information

VT 1110						
			UC1707-SP			
THERMAL METRIC ⁽¹⁾		J (CDIP)	FK (LCCC)	W (CFP)	UNIT	
		16 PINS	20 PINS	16 PINS		
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	36	31.8	53.6	°C/W	
$R_{\theta JB}$	Junction-to-board thermal resistance	55.2	31.3	105	°C/W	
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	9.5	2.8	4.2	°C/W	

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

6.5 Electrical Characteristics

Unless otherwise stated, these specifications apply for $T_A = -55^{\circ}C$ to 125°C; $V_{IN} = V_C = 20$ V. $T_A = T_J$.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{IN}	Supply current	V _{IN} = 40 V		12	15	mA

⁽²⁾ All voltages are with respect to the four ground pins which must be connected together. All currents are positive into, negative out of the specified terminal. Digital drive can exceed 5.5 V if input current is limited to 10 mA. Consult packaging section of datasheet for thermal limitations and considerations of package.



Electrical Characteristics (continued)

Unless otherwise stated, these specifications apply for $T_A = -55$ °C to 125°C; $V_{IN} = V_C = 20$ V. $T_A = T_J$.

	PARAMETER	TEST	CONDITIONS	MIN	TYP	MAX	UNIT
V _C	Supply current	$V_C = 40 \text{ V}$, outputs low	$V_C = 40 \text{ V}$, outputs low			7.5	mA
V _C	Leakage current	$V_{IN} = 0, V_C - 30 V, no$	load		0.05	0.1	mA
	Digital input low level					0.8	V
	Digital input high level			2.2			٧
	Input current	V _I = 0			-0.06	-1.0	mA
	Input leakage	V _I = 5 V	V _I = 5 V		0.05	0.1	mA
$V_C - V_O$	Output high sat	$I_{O} = -50 \text{ mA}$	$I_{O} = -50 \text{ mA}$			2.0	٧
		$I_{O} = -500 \text{ mA}$	$I_{O} = -500 \text{ mA}$			2.5	٧
.,		$I_O = -50 \text{ mA}$	$I_O = -50 \text{ mA}$			0.4	V
Vo	Output low sat	$I_{O} = -500 \text{ mA}$				2.5	٧
	A l d l - l - l	V 0 (- 45 V	8761901	100	130	150	mV
	Analog threshold	$V_{CM} = 0$ to 15 V	8761903	90	130	150	mV
	Input bias current	V _{CM} = 0	V _{CM} = 0		-10	-20	μΑ
	Thermal shutdown				155		°C
	Shutdown threshold	Pin 7 input		0.4	1.0	2.2	٧
	Latch disable threshold	Pin 3 input		0.8	1.2	2.2	V

6.6 Typical Switching Characteristics

 $V_{IN} = V_{C} = 20 \text{ V}$, $T_{A} = 25^{\circ}\text{C}$. Delays measured to 10% output change.

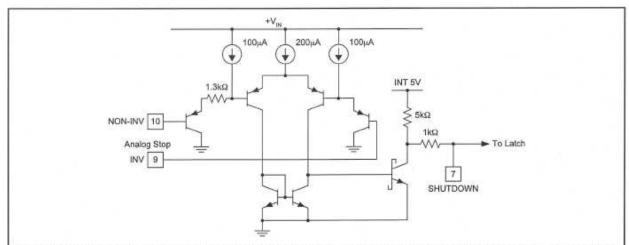
PARAMETER	TEST CONDITIONS	OUTPUT CL =			UNIT
FROM INV. INPUT TO OUTPUT		open	1.0	2.2	nF
Rise time delay		40	50	60	ns
10% to 90% rise		25	40	50	ns
Fall time delay		30	40	50	ns
90% to 10% fall		25	40	50	ns
FROM N.I. INPUT TO OUTPUT					
Rise time delay		30	40	50	ns
10% to 90% rise		25	40	50	ns
Fall time delay		45	55	65	ns
90% to 10% fall		25	40	50	ns
V _C Cross-conduction current spike duration	Output rise	25			ns
	Output fall	0			ns
Analog shutdown delay	Stop non-Inv. = 0 V	180			ns
	Stop Inv. = 0 to 0.5 V	180			ns
Digital shutdown delay	2 V input on Pin 7	50			ns

Product Folder Links: UC1707-SP



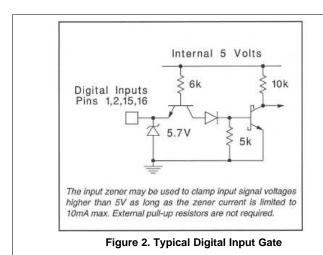
7 Parameter Measurement Information

7.1 Simplified Internal Circuitry



The input common-mode voltage range is from ground to (VIN-3V). When not used both inputs should be grounded. Activate time is a function of overdrive with a typical value of 180ns. Pin 7 serves both as a comparator output and as a common digital shutdown input. A high signal here will accomplish the fastest turn off of both outputs. Note that "OFF" is defined as the outputs low. Pulling shutdown low defeats the latch operation regardless of its status.

Figure 1. Typical Digital Input Gate



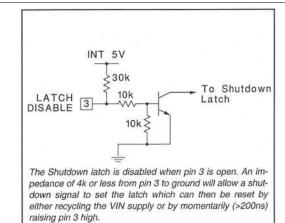
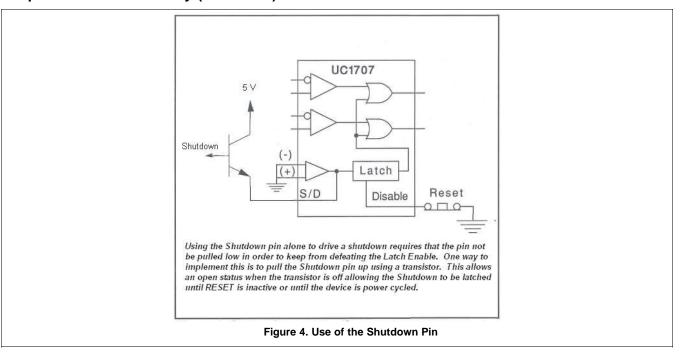


Figure 3. Latch Disable



Simplified Internal Circuitry (continued)



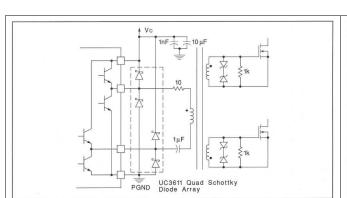


Figure 5. Transformer Coupled Push-Pull MOSFET Drive

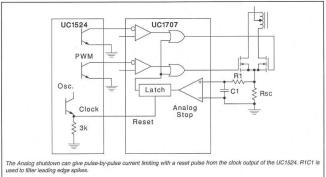


Figure 6. Current Limiting

TEXAS INSTRUMENTS

Simplified Internal Circuitry (continued)

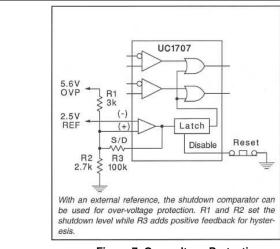


Figure 7. Overvoltage Protection

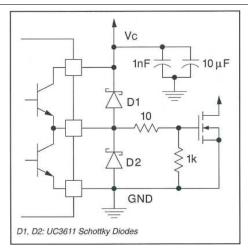


Figure 8. Power MOSFET Drive Circuit

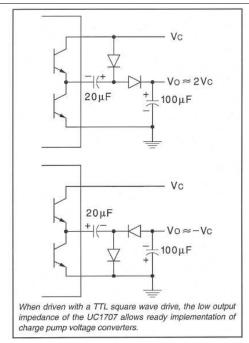


Figure 9. Charge Pump Circuits

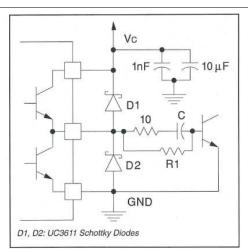


Figure 10. Power Bipolar Drive Circuit

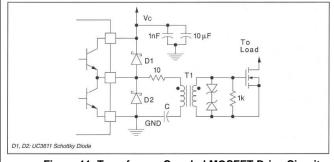


Figure 11. Transformer Coupled MOSFET Drive Circuit

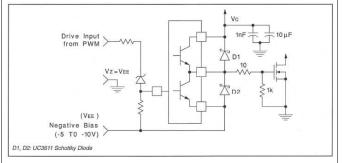


Figure 12. Power MOSFET Drive Circuit Using Negative Bias Voltage and Level Shifting to Ground Reference PWM

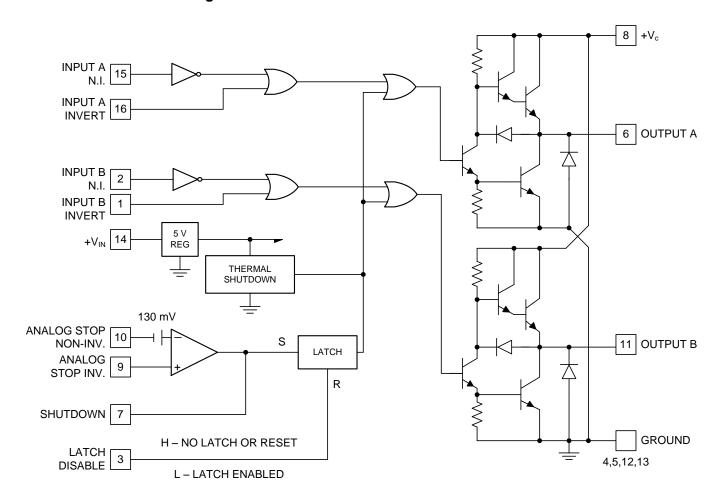


8 Detailed Description

8.1 Overview

UC1707-SP was designed specifically as a power MOSFET driver for switching-mode power supply applications. It is capable of providing fast transitions and high-peak current required by power MOSFETs. One of the most important factors while developing the UC1707-SP was to isolate the high speed switching noise from the low level analog signals at the PWM. Separate supply and return paths at the driver signal inputs and power outputs further enhance noise immunity.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Shutdown Circuit Description

The function of the circuitry is to be able to provide a shutdown of the device. This is defined as functionality that will drive both outputs to the low state. There are three different inputs that govern this shutdown capability.

- Analog Stop Pins The differential inputs to this comparator provide a way to execute a shutdown.
- Latch Disable Pin Assuming that the Shutdown pin is left open, a high on this pin disables the latching functionality of the Analog Stop shutdown. A low on this pin enables the latching functionality of the Analog Stop shutdown. If a shutdown occurs through the Analog Stop circuit while Latch Disable is high, then the outputs will go low, but will return to normal operation as soon as the Analog Stop circuit allows it. If a shutdown occurs through the Analog Stop circuit while Latch Disable is low, then the outputs will go low and remain low even if the Analog Stop circuit no longer drives the shutdown. The outputs will remain "latched" low (in shutdown) until the Latch Disable goes high and the Analog Stop circuit allows it to return from shutdown or the VIN voltage is cycled to 0 V and then returned above 5 V.

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Feature Description (continued)

- Shutdown Pin This pin serves two purposes.
 - 1. It can be used as an output of the Analog Stop circuit.
 - 2. It can be used as an input to force a shutdown or to force the device out of shutdown. This pin can override both the Analog Stop circuit as well as the Latch Disable Pin. When driving hard logic levels into the Shutdown pin, the Latch Disable functionality will be overridden and the Latch Disable will not function as it does when used in conjunction with the Analog Stop circuit. When the Shutdown pin is high, the outputs will be in the low state (shutdown). When the Shutdown pin is low (hard logic low) the outputs will operate normally, regardless of the state of the Latch Disable pin or the Analog Stop pins.

To use the Shutdown Pin with the Latch Disable functional it is necessary to use either a diode in series with the Shutdown signal or to use an open collector pullup so that the Shutdown pin is not pulled low. This configuration will allow the Latch Disable function to work with the Shutdown pin.

8.4 Device Functional Modes

Table 1. UG1707 Shutdown Truth Table

ANALOG STOP LOGIC	SHUTDOWN	LATCH DISABLE	PREVIOUS STATE OF OUTPUT	ОИТРИТ
X	0	X	Χ	Follows Input Logic
X	1	X	Χ	Low (Shutdown)
1	Open	X	Χ	Low (Shutdown)
0	Open	0	Shutdown	Latched Shutdown (1)
0	Open	0	Normal	Follows Input Logic
0	Open	1	X	Follows Input Logic

⁽¹⁾ If the output was previously in Shutdown and Latch Disable was low and stays low, then even if the Analog Stop Logic is changed or the Shutdown pin is open, the outputs will remain in Shutdown.

Submit Documentation Feedback

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9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

UC1707-SP MOSFET driver IC is designed to provide fast transition and high peak currents required for the MOSFETs. Each driver features TTL compatible input thresholds, undervoltage lockout, thermal shutdown and low cross conduction, high-speed output circuitry. The peak current of each totem-pole output, whether source or sink is 1.5 A. However, on dual output versions as in UC1707-SP both of the outputs can be paralleled for 3-A peak current.

9.2 Typical Application

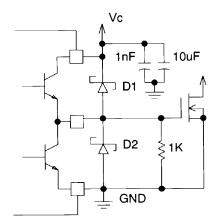


Figure 13. Power MOSFET Drive Circuit

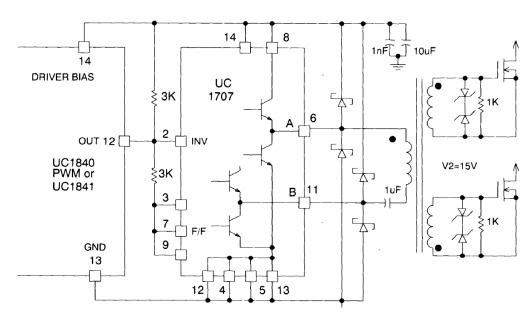


Figure 14. Convert Single Output PWMS High-Current Push-Pull Configuration



Typical Application (continued)

9.2.1 Design Requirements

Push-Pull Transformer coupling – driving MOSFETs with transformer coupled winding.

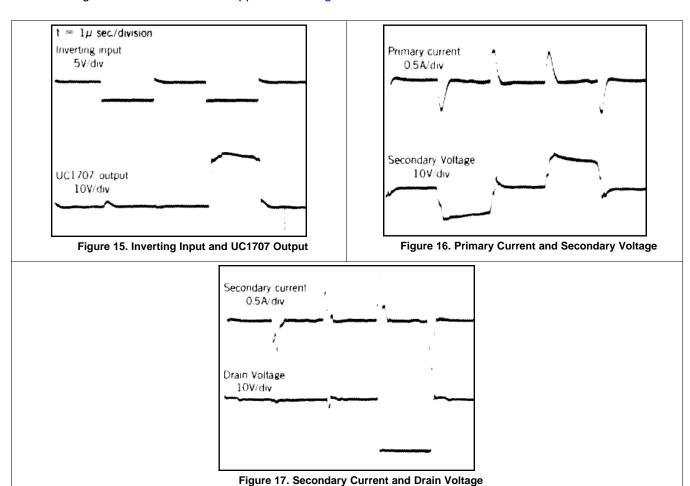
9.2.2 Detailed Design Procedure

The totem-pole outputs of the UC1707-SP can easily be configured for implementing the balanced transformer drive as shown in Figure 14. Output A and B are alternating now as the internal flip-flop is active and the output frequency is halved. When the UC1707-SP output goes high, the other is held low during the dead time between output pulses. With balanced operation, no coupling capacitor on the primary is necessary since there is no net DC in the primary. Schottky clamp diodes on the primary side and back to back Zener diodes on the secondary are necessary to minimize the overshoot caused by the ringing of the gate capacitance with circuit inductances.

9.2.3 Application Curves

 $t = 1 \mu s/DIV$.

The following waveforms refer to the application in Figure 14.





10 Power Supply Recommendations

It is important that the localized capacitors be placed close to the driver V_C/V_{IN} pins. Layout is critical to ensure that the driver is placed close to the MOSFETs that are being driven Adding Schottky diodes prevent the negative transition (below ground) at the derived outputs.

11 Layout

11.1 Layout Guidelines

Directly connecting the MOSFET gate to the output of the driver is straighforward for testing purposes. It does not represent the "real" application which may include several inches of printed circuit board traces. Inductance will sharply degrade the transitions and cause substantial overshoot by ringing with the gate capacitance. This can cause the gate-to-source voltage to overshoot beyond the specified maximum ratings. Additionally, negative transitions (below ground) at the driver output can raise havoc with the internal circuitry, leading to undesirable performance.

Adding Schottky diodes to auxiliary supply rail can help address these concerns.

11.2 Layout Example

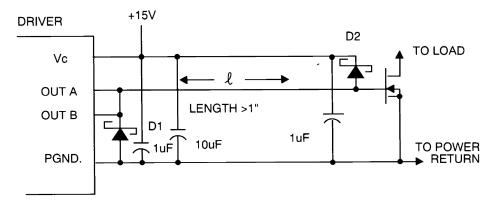


Figure 18. Layout



12 Device and Documentation Support

12.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Lise

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.2 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

12.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





25-Oct-2016

PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins		Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
5962-8761901V2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962- 8761901V2A UC1707L QMLV	Samples
5962-8761901VEA	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-8761901VE A UC1707JQMLV	Samples
5962-8761903V2A	ACTIVE	LCCC	FK	20	1	TBD	POST-PLATE	N / A for Pkg Type	-55 to 125	5962- 8761903V2A UC1707L-SP	Samples
5962-8761903VEA	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-8761903VE A UC1707J-SP	Samples
5962-8761903VFA	ACTIVE	CFP	W	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-8761903VF A UC1707W-SP	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



PACKAGE OPTION ADDENDUM

25-Oct-2016

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF UC1707-SP:

Catalog: UC1707

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

W (R-GDFP-F16)

CERAMIC DUAL FLATPACK



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within MIL STD 1835 GDFP2-F16



14 LEADS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

FK (S-CQCC-N**)

LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. Falls within JEDEC MS-004



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